

Search Notes				Application/Control No.	Applicant(s)/Patent under Reexamination	
				09/805,887	LAROIA ET AL.	
Examiner				Art Unit		
Steven HD Nguyen				2665		
SEARCHED				SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
Class	Subclass	Date	Examiner	DATE	EXMR	
370	203-210	7/5/2005	ST	EAST IFFT and Interpolator	7/5/2005	ST
375	260-261					
	270, 296					
	298, 301					
	346, 348					
INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			